

BSI Standards Publication

Photonic integrated circuits

Part 1: Introduction and roadmap for standardization



National foreword

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TECHNICAL REPORT



Photonic integrated circuits – Part 1: Introduction and roadmap for standardization





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TECHNICAL REPORT



Photonic integrated circuits –
Part 1: Introduction and roadmap for standardization

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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CONTENTS

Г		KU	
1	Scop	e	7
2	Norm	ative references	7
3	Term	s and definitions	7
4	Photo	onic integrated circuit (PIC)	9
	4.1	Overview	
	4.2	PIC families	
	4.2.1	General	11
	4.2.2	Silicon photonics	12
	4.2.3	III-V photonics	12
	4.2.4	Silica and silicon nitride PICs	12
	4.3	Manufacturing capabilities	13
	4.4	Global market	13
	4.5	Global government investment in PIC research and development	
	4.5.1		
	4.5.2		
	4.5.3	'	
	4.5.4	•	
5	Silico	on photonics	
	5.1	Overview	
	5.2	Integration schemes	
	5.2.1		
	5.2.2	3	
	5.2.3	8	
_	5.3	Non-linear behaviour	
6		photonics	
_	6.1	Indium phosphide (InP) photonics	
7		ransceiver – A simple example	
	7.1	Overview	
	7.2	Transmitter section	
_	7.3	Receiver section	
8	•	al sources	
	8.1	Overview	
	8.2	Advances in III-V integration onto silicon PICs	
_	8.3	Vertical cavity surface emitting lasers (VCSELs)	
9	•	al receivers	
10	Modu	ılators	
	10.1	Overview	
	10.2	Common modulator structures	
	10.3	Plasma dispersion effect	
	10.4	Plasmonics	
٠,	10.5	Silicon organic hybrid	
11		ches	
	11.1	Overview	
	11.2	Mach-Zehnder interferometers (MZI)	
	11.3	Micro-ring resonator (MRR)	24

11.4	Double-ring assisted MZI (DR-MZI)	. 25
12 3D ii	ntegration	. 25
12.1	Optochip	. 25
12.2	Through-silicon-vias (TSVs)	
12.3	Hybrid integration process example	
12.4	Flip-chip bonding	
12.5	State of the art in 3D research and development	
13 Com	mercial state of the art	
13.1	Overview	
13.2	Luxtera	
13.3	Intel	
13.4	Mellanox	
13.5	Oracle	
13.6	IBM	
13.7	Photonics Electronics Technology Research Association (PETRA)	
14 PIC	coupling interfaces	
14.1	Overview	
14.2	Grating coupler	
14.3	Adiabatic coupling	
14.4	Butt coupling	
14.5	Orthogonal chip-to-fibre coupling	
	trical interface	
	(aging	
	dardization roadmap	
	phy	
ыынодга	priy	. 39
Eiguro 1	– Examples of PICs [1]	11
•	Optical beam forming network fabricated in TriPleX (silicon nitride)	
•	– Typical silicon waveguides [6]	
Figure 4	– Heterogeneous integration by flip chip and copper pillars	.15
Figure 5	– Indium phosphide PIC with many structures, including AWG	. 16
Figure 6	- Combined InP and TriPleX microwave photonic beam-forming network	.17
Figure 7	- Schematic of four channel PIC transceiver by Luxtera [6]	.18
	- Schematic view of 3D assembly of PIC + EIC electro-optical assembly [6]	
_	 Example of Ge-on-Si photodetector formed by germanium selective epitaxy [6]. 	
•) – High speed PN modulator [6]	
•		
•	- PETRA optical I/O core chip modulation scheme	
_	2 – Silicon organic hybrid	. 24
	B – 4 x 4 switching matrix PIC attached to PCB with wire bonds on the EU xTroT project	. 25
Figure 14	- EU FP7 project PhoxTroT 3D integrated optochip concept	.26
Figure 15	5 – LIFT principle	.27
_	5 – PETRA optical I/O core performance at 25 Gb/s	
•	/ – Examples of vertical grating couplers [6]	
•		
	B – Coupling efficiency of single polarization grating coupler (SPGC) at 1 310 490 nm [91]	. 32

- 4 - IEC TR 63072-1:2017 © IEC 2017

Figure 19 – Composite coupling interfaces on PETRA optical I/O core	32
Figure 20 – Assembly for adiabatic optical coupling between Si photonics chip and SM polymer waveguide	33
Figure 21 – Flip-chipped silicon photonic chip onto polymer waveguide substrate using adiabatic coupling	34
Figure 22 – Bidirectional optical coupling between SOI waveguides and single polymer waveguides	35
Figure 23 – Design of the mirror plug assembly	36
Figure 24 – Typical operative framework of silicon-photonics modules	37
Figure 25 – PIC standardization roadmap	38

INTERNATIONAL ELECTROTECHNICAL COMMISSION

PHOTONIC INTEGRATED CIRCUITS -

Part 1: Introduction and roadmap for standardization

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IEC TR 62072-1, which is a Technical Report, has been prepared by subcommittee 86C: Fibre optic systems and active devices, of IEC technical committee 86: Fibre optics.

The text of this Technical Report is based on the following documents:

Enquiry draft	Report on voting
86C/1428/DTR	86C/1441/RVDTR

Full information on the voting for the approval of this technical report can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 63072-1 series, published under the general title *Photonic integrated circuits*, can be found on the IEC website.

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PHOTONIC INTEGRATED CIRCUITS -

Part 1: Introduction and roadmap for standardization

1 Scope

This part of IEC 63072, which is a Technical Report, provides an introduction to photonic integrated circuits (PICs) and describes a roadmap for the standardization of PIC technology over the next decade.

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2 Normative references

There are no normative references in this document.

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- IEC Electropedia: available at http://www.electropedia.org/
- ISO Online browsing platform: available at http://www.iso.org/obp

3.1

photonic integrated circuit

. PIC

integrated circuit that contains optical structures to guide and process optical signals

3.2

III-V

three-five

compound semiconductor formed of materials from the third and fifth column of the periodic table

EXAMPLE 1 Indium phosphide

EXAMPLE 2 Gallium arsenide

3.3

through-silicon-via

TSV

metallised hole (via) through a silicon wafer enabling electrical conductivity from one surface of the silicon to the other

3.4

silicon photonics

structure or system of structures fabricated into a silicon wafer to guide light and enable passive and active optical processes to be carried out at the integrated circuit level